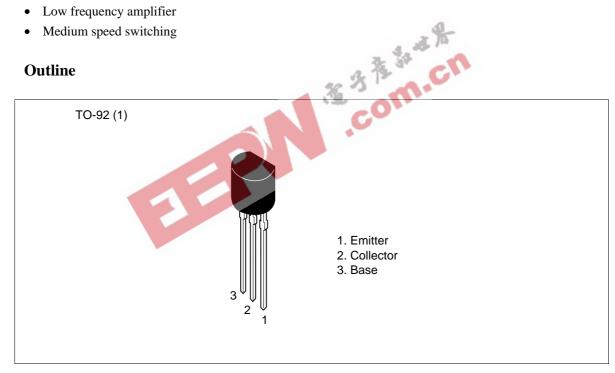
Silicon PNP Epitaxial

# **HITACHI**

### **Application**

- Low frequency amplifier
- Medium speed switching

#### **Outline**





#### **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit
Collector to base voltage	$V_{\scriptscriptstyle \sf CBO}$	-50	V
Collector to emitter voltage	$V_{\text{CEO}}$	<b>–</b> 50	V
Emitter to base voltage	$V_{EBO}$	-4	V
Collector current	I <sub>c</sub>	-0.5	А
Collector power dissipation	P <sub>c</sub>	0.4	W
Junction temperature	Tj	150	°C
Storage temperature	Tstg	-55 to +150	°C



# Electrical Characteristics ( $Ta = 25^{\circ}C$ )

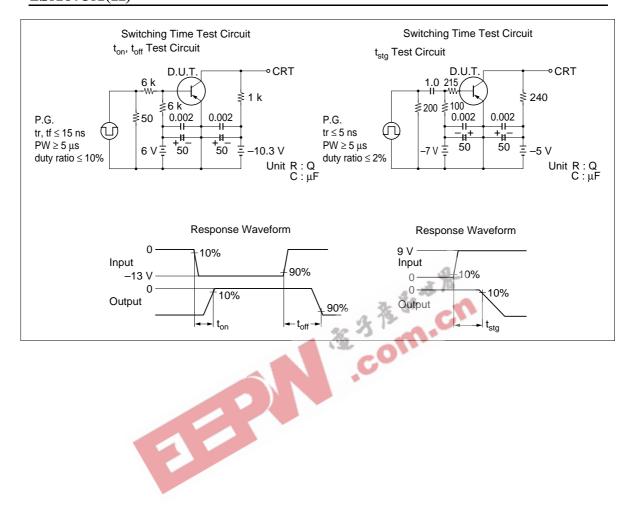
Item	Symbol	Min	Тур	Max	Unit	Test conditions
Collector to base breakdown voltage	$V_{(BR)CBO}$	-50	_	_	V	$I_{\rm C} = -10 \ \mu A, \ I_{\rm E} = 0$
Collector to emitter breakdown voltage	$V_{(BR)CEO}$	-50	_	_	V	$I_{\rm C} = -1 \text{ mA}, R_{\rm BE} = \infty$
Emitter to base breakdown voltage	$V_{(BR)EBO}$	-4	_	_	V	$I_{E} = -10 \mu A, I_{C} = 0$
Collector cutoff current	I <sub>CBO</sub>	_	_	-0.5	μΑ	$V_{CB} = -20 \text{ V}, I_{E} = 0$
Emitter cutoff current	$I_{EBO}$	_	_	-0.5	μΑ	$V_{EB} = -3 \text{ V}, I_{C} = 0$
Base to emitter voltage	$V_{BE}$	_	-0.64	_	V	$V_{EB} = -3 \text{ V}, I_{C} = -10 \text{ mA}$
Collector to emitter saturation voltage	$V_{CE(sat)}$	_	-0.2	-0.6	V	$I_{\rm C} = -150 \text{ mA}, I_{\rm B} = -15 \text{ mA*}^2$
Base to emitter saturation voltage	$V_{\text{BE}(\text{sat})}$	_	-0.87	九為	V	$I_{\rm G} = -150 \text{ mA}, I_{\rm B} = -15 \text{ mA}^{*2}$
DC current transfer ratio	h <sub>FE</sub> *1	60	- 30	320	W.	$V_{CE} = -3 \text{ V}, I_{C} = -10 \text{ mA}$
	$h_{\text{FE}}$	10	<b>E</b> ""	<del>7</del> 20		$V_{CE} = -3 \text{ V}, I_{C} = -500 \text{ mA}^{*2}$
Gain bandwidth product	f <sub>T</sub>	+ $+$	120	-	MHz	$V_{CE} = -3 \text{ V}, I_{C} = -10 \text{ mA}$
Turn on time	ton	<del>-)</del> `\	0.3	_	μs	$V_{cc} = -10.3 \text{ V}$
Turn off time	t <sub>off</sub>		0.6		μs	$I_{\rm C} = 10 I_{\rm B1} = -10 I_{\rm B2} = -10  \rm mA$
Storage time	t <sub>stg</sub>	_	0.4	_	μs	$V_{CC} = -5 \text{ V},$ $I_{C} = I_{B1} = I_{B2} = -20 \text{ mA}$

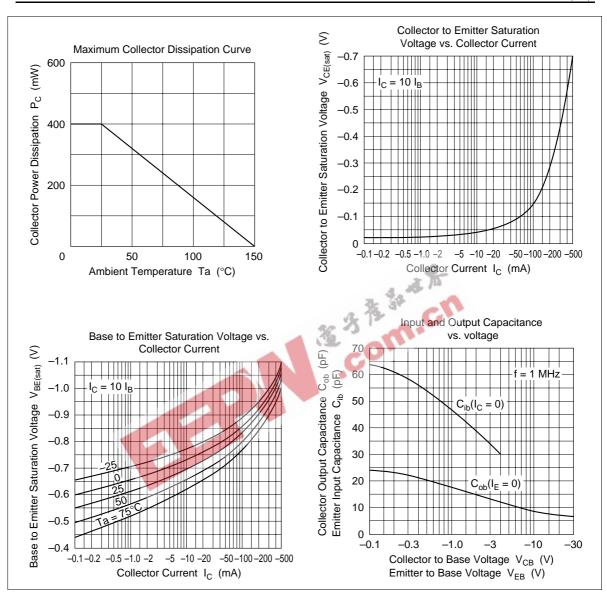
Notes: 1. The 2SA673A(K) is grouped by h<sub>FE</sub> as follows.

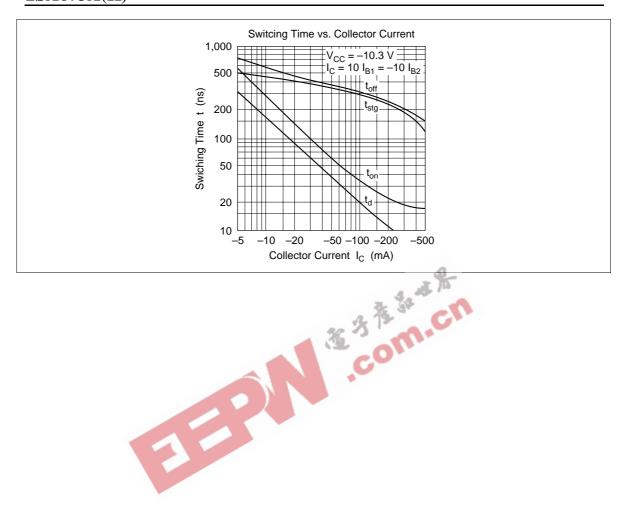
2. Pulse test

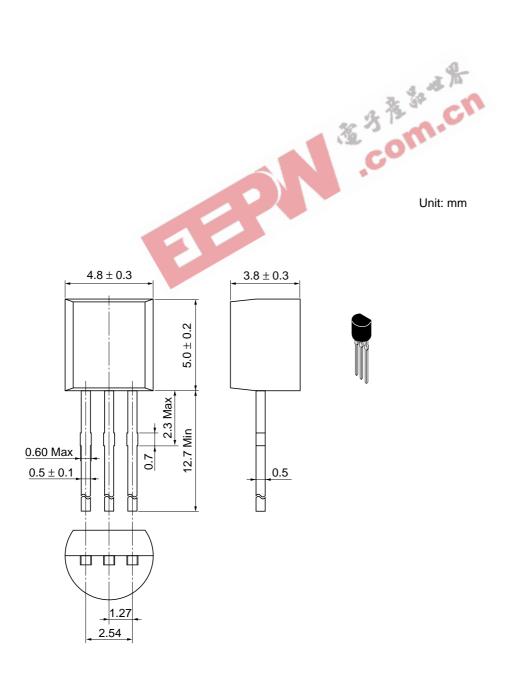
В	С	D	
60 to 120	100 to 200	160 to 320	

See 2SA673A except for the above – mentioned characteristic curves.









Hitachi Code	TO-92 (1)
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.25 a

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